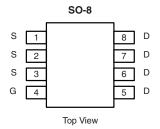


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P-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 30			
$R_{DS(on)}(\Omega)$ at $V_{GS} = -10 \text{ V}$	0.0085			
$R_{DS(on)}(\Omega)$ at $V_{GS} = -4.5 \text{ V}$	0.0200			
I _D (A)	- 22			
Configuration	Single			

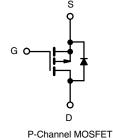


FEATURES

- TrenchFET® Power MOSFET
- ESD Protection: 3000 V
- 100 % R_g and UIS Tested
- AEC-Q101 Qualified^c



RoHS COMPLIANT HALOGEN FREE



ORDERING INFORMATION	
Package	SO-8
Lead (Pb)-free and Halogen-free	DTM4483

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)					
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V_{DS}	- 30	V	
Gate-Source Voltage		V _{GS}	± 20		
Continuous Drain Current	T _C = 25 °C	1	- 22		
Continuous Drain Current	T _C = 125 °C	- I _D	- 13		
Continuous Source Current (Diode Conduction)		I _S	- 6	Α	
Pulsed Drain Current ^a		I _{DM}	- 84		
Single Pulse Avalanche Current	L = 0.1 mH	I _{AS}	- 50		
Single Pulse Avalanche Energy	L=0.1 min	E _{AS}	125	mJ	
Maximum Power Dissipation ^a	T _C = 25 °C	⊢ Pn	7	W	
	T _C = 125 °C		2	VV	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C	

THERMAL RESISTANCE RATINGS				
PARAMETER		SYMBOL	LIMIT	UNIT
Junction-to-Ambient	PCB Mount ^b	R_{thJA}	85	°C/W
Junction-to-Foot (Drain)	o-Foot (Drain)		21	C/VV

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %. b. When mounted on 1" square PCB (FR-4 material).
- c. Parametric verification ongoing.



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PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$		- 30	-	-	V
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = -250 \mu A$		- 2.0	- 2.5	
Octo Course Leeline		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$		-	-	± 1	mA
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$		-	-	± 2	
		$V_{GS} = 0 V$	V _{DS} = - 30 V	-	-	- 1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V$	V _{DS} = - 30 V, T _J = 125 °C	-	-	- 50	μA
		V _{GS} = 0 V	V _{DS} = - 30 V, T _J = 175 °C	-	-	- 150	
On-State Drain Current ^a	I _{D(on)}	V _{GS} = - 10 V	V _{DS} ≤ - 5 V	- 30	-	-	Α
		V _{GS} = - 10 V	I _D = - 10 A	-	0.0070	0.0085	Ω
Dunin Course On Otata Basistanas		V _{GS} = - 10 V	I _D = - 10 A, T _J = 125 °C	-	-	0.0130	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 10 A, T _J = 175 °C	-	-	0.0150	
		V _{GS} = - 4.5 V	I _D = - 7 A	-	0.0160	0.0200	
Forward Transconductance ^b	9 _{fs}	V _{DS} = - 10 V, I _D = - 10 A		-	32	-	S
Dynamic ^b							
Output Capacitance	C _{oss}	V _{GS} = 0 V	V _{DS} = - 15 V, f = 1 MHz	-	712	890	pF
Total Gate Charge ^c	Qg			-	75	113	
Gate-Source Charge ^c	Q _{gs}	V _{GS} = - 10 V	$V_{DS} = -15 \text{ V}, I_{D} = -10 \text{ A}$	-	9.5	-	nC
Gate-Drain Charge ^c	Q _{gd}	7		-	19	-	
Gate Resistance	R _g	f = 1 MHz		6	12.82	20	Ω
Turn-On Delay Time ^c	t _{d(on)}			-	38	57	
Rise Time ^c	t _r	V_{DD} = - 15 V, R_L = 1.5 Ω $I_D \cong$ - 10 A, V_{GEN} = - 10 V, R_g = 1 Ω		-	82	123	ns
Turn-Off Delay Time ^c	t _{d(off)}			-	134	201	
Fall Time ^c	t _f			-	178	214	
Source-Drain Diode Ratings and Char	acteristics ^b						
Pulsed Current ^a	I _{SM}			-	-	- 84	Α
Forward Voltage	V_{SD}	I _F = - 3 A, V _{GS} = 0 V		-	- 0.75	- 1.2	V

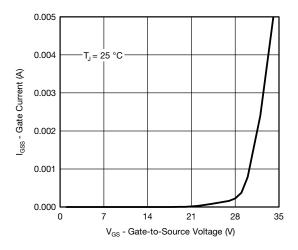
Notes

- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

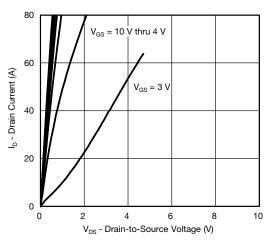
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



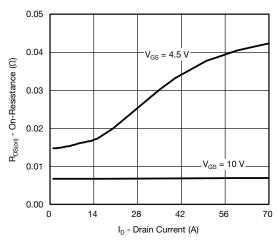
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



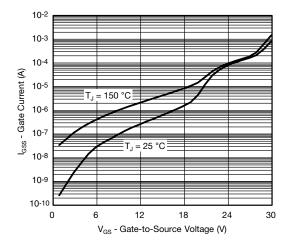
Gate Current vs. Gate-Source Voltage



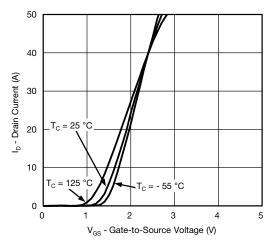
Output Characteristics



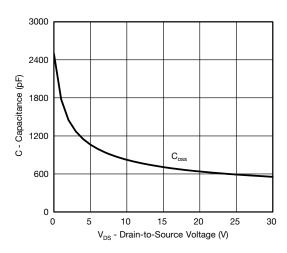
On-Resistance vs. Drain Current



Gate Current vs. Gate-Source Voltage



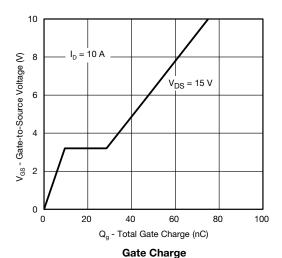
Transfer Characteristics

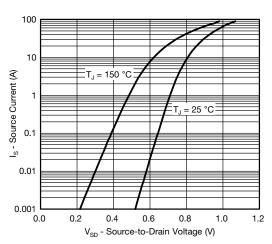


Capacitance

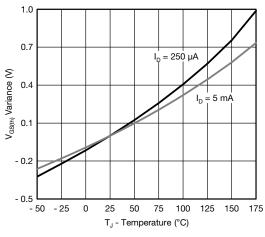


TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

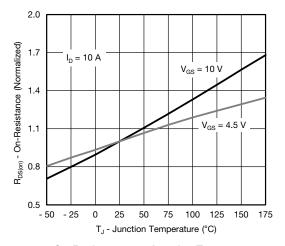




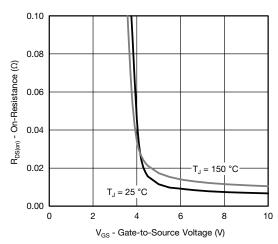
Source Drain Diode Forward Voltage



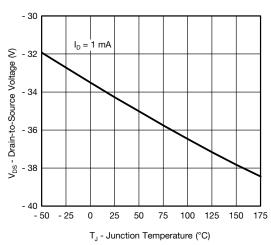
Threshold Voltage



On-Resistance vs. Junction Temperature



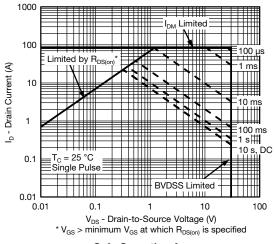
On-Resistance vs. Gate-to-Source Voltage



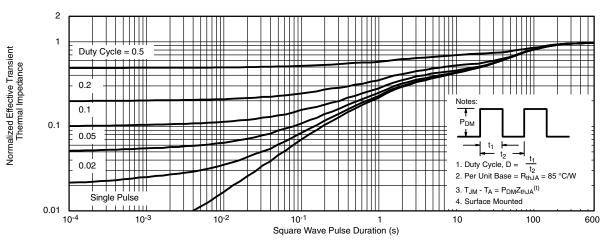
Drain Source Breakdown vs. Junction Temperature



THERMAL RATINGS ($T_A = 25 \, ^{\circ}\text{C}$, unless otherwise noted)



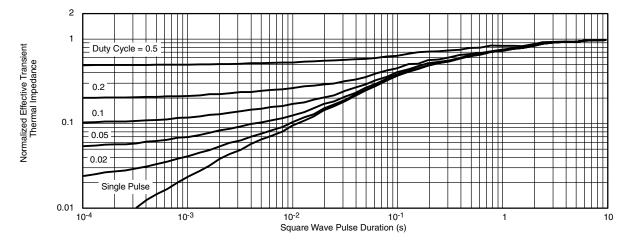
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient

THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)

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Normalized Thermal Transient Impedance, Junction-to-Foot

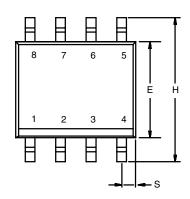
Note

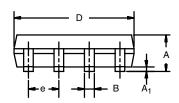
- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction-to-Foot (25 °C)

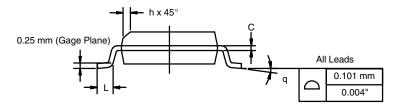
are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions.



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012





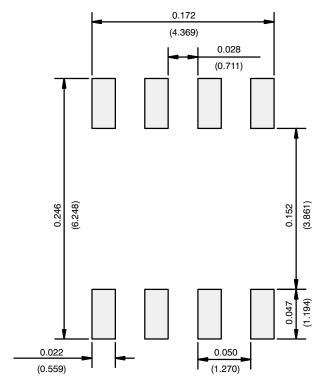


	MILLIM	IETERS	INC	HES	
DIM	Min	Max	Min	Max	
Α	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
Е	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050	BSC	
Н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev I 11-Sep-06					

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498

RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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